Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | EGAWA, YOSUKE | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0043462	02-2005	Yamada et al.	524/445
*	В	US-6,326,440	12-2001	Terada et al.	525/411
	С	US-			
	ם	US-			
	Е	US-			
	F	US-			
	·G	US-			
	Ι	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2001049098 A	02-2001	Japan	OBUCHI et al.	
	0			T.		
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	English translation of JP 2001049098A
	\ \	
	w	
	x	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.